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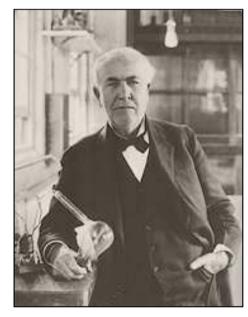
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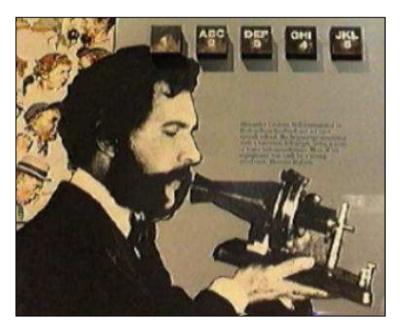
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Founding officers of the American Institute of Electrical Engineers in 1884:



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Alexander Graham Bell



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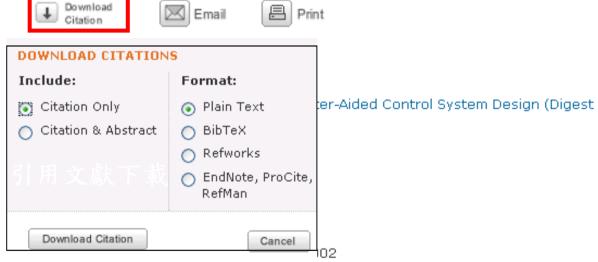
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Abstract

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Integration using a unified model for CACSD





ABSTRACT

This paper presents an approach to the definition of an object-oriented integrated environment for computer-aided control systems design. Today's specialised CACSD tools are software programs that deal in detail with single processes of control systems design. Such tools offer better control of the processes they model than generic CACSD packages-all-in-one tools with



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5. F00N 0. 7004 404

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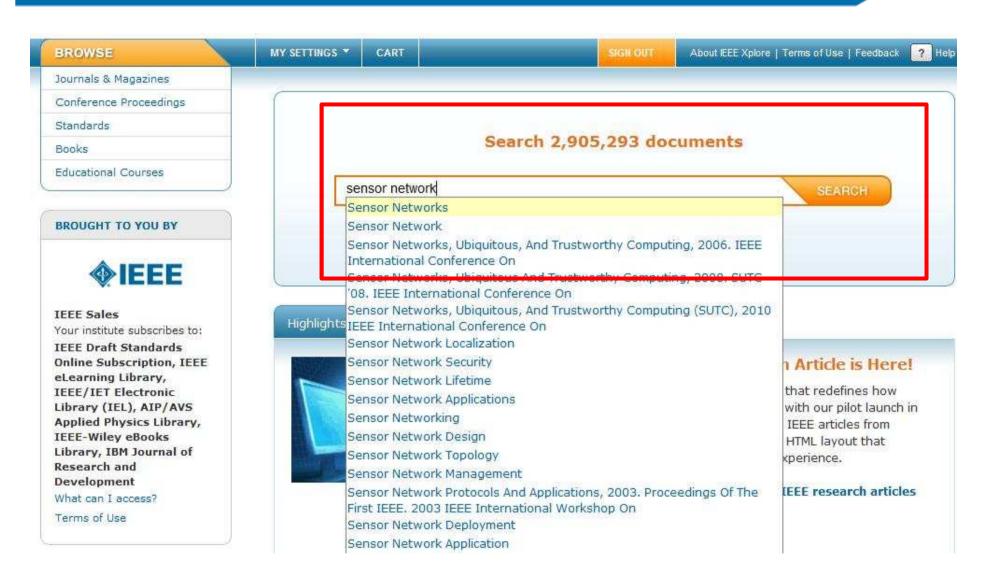
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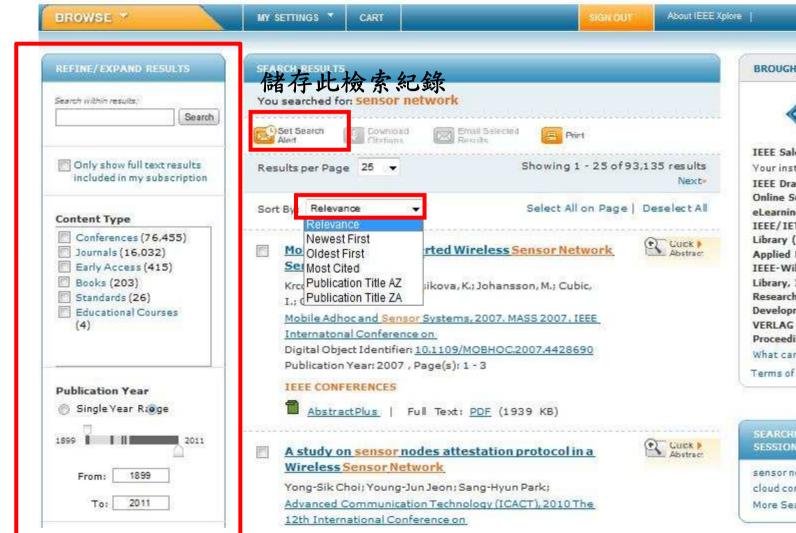


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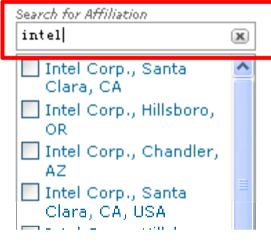


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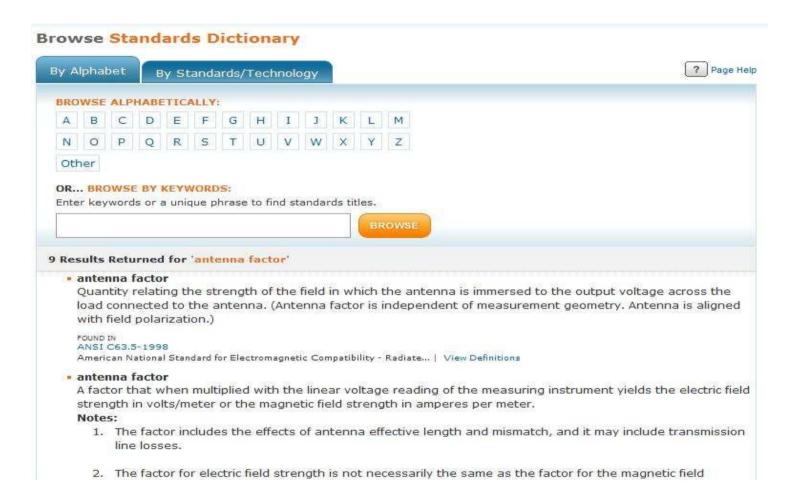
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issues and directions in each area. Wide area sensor network ************************************	lunker, Robert; Brentano, Josef; I	Chona, Dhiren	SPIE
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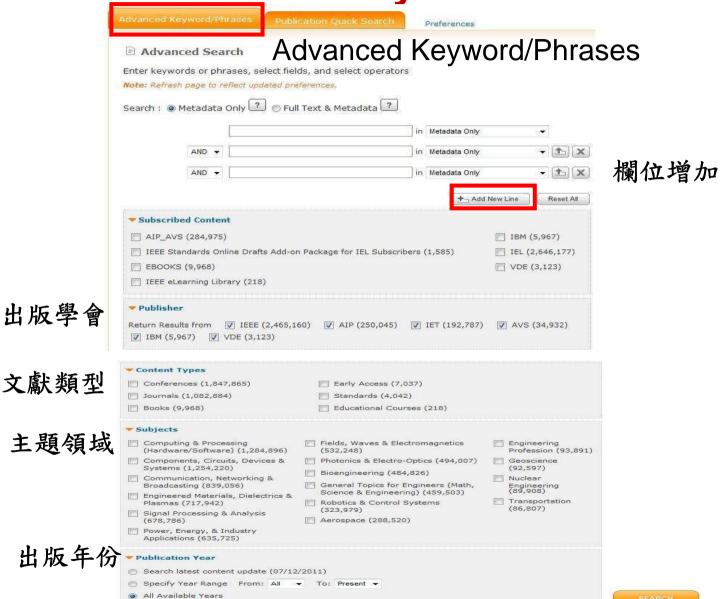


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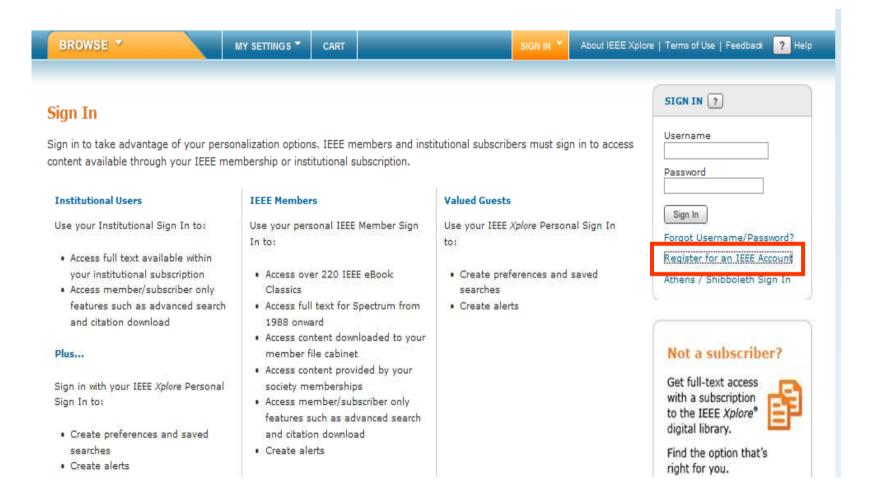


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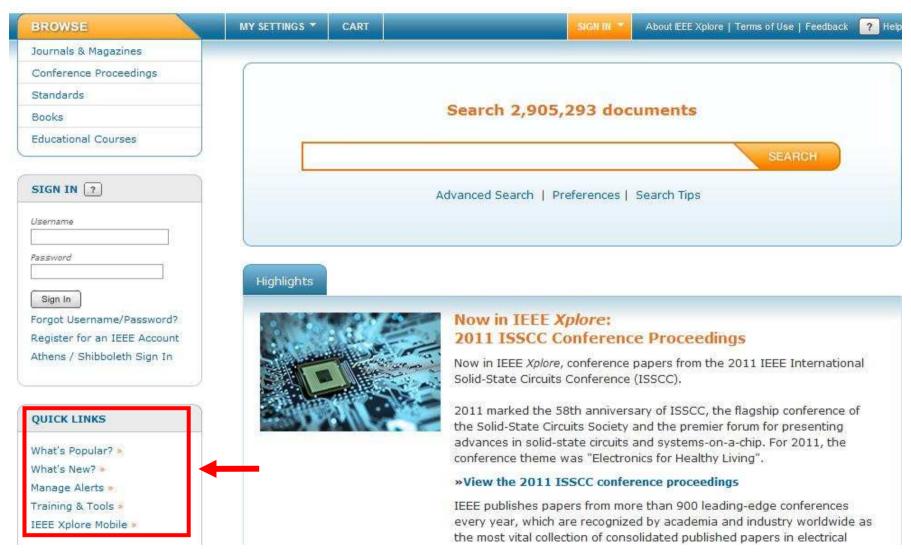


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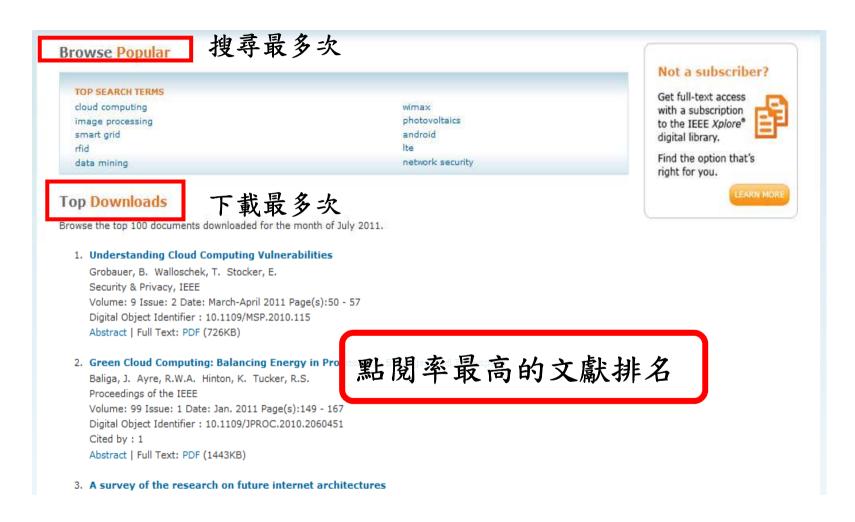


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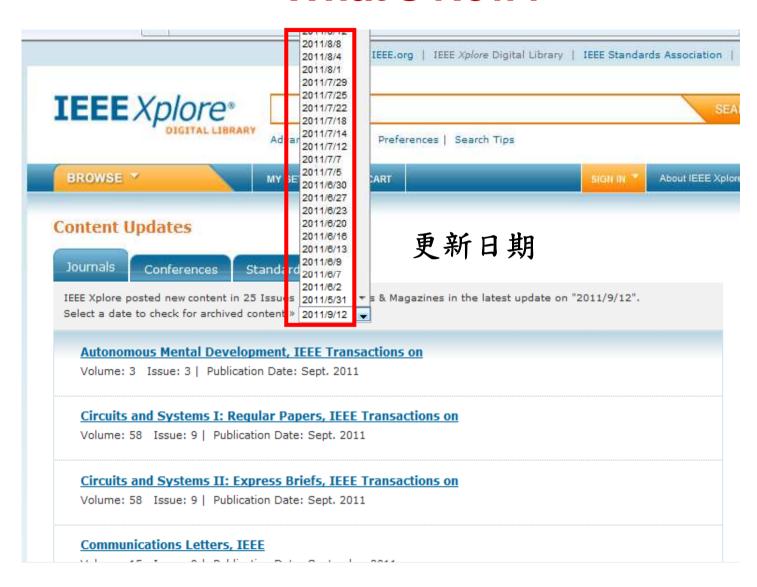


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